



8-Bit Bidirectional Voltage-Level Translator for Open-Drain and Push-Pull Applications

FEATURES

- No Direction-Control
- Data Rates 24Mbps (Push-Pull) 2Mbps (Open-Drain)
- 1.65V to 5.5V on A ports and 2.3V to 5.5V on B Ports (V_{CCA}≤V_{CCB})
- V_{CC} Isolation: If Either V_{CC} is at GND, Both Ports are in the High-Impedance State
- No Power-Supply Sequencing Required: Either V_{CCA} or V_{CCB} can be Ramped First
- IOFF: Supports Partial-Power-Down Mode Operation
- Extended Temperature: -40°C to +85°C

APPLICATIONS

- Handset
- Smartphone
- Tablet
- Desktop PC

DESCRIPTION

This 8-bit non-inverting translator is a bidirectional voltagelevel translator and can be used to establish digital switching compatibility between mixed-voltage systems. It uses two separate configurable power-supply rails, with the A ports supporting operating voltages from 1.65V to 5.5V while it tracks the V_{CCA} supply, and the B ports supporting operating voltages from 2.3V to 5.5V while it tracks the V_{CCB} supply. This allows the support of both lower and higher logic signal levels while providing bidirectional translation capabilities between any of the 1.8V, 2.5V, 3.3V and 5V voltage nodes.

When the output-enable (OE) input is low, all I/Os are placed in the high-impedance state, which significantly reduces the power-supply quiescent current consumption. OE has an internal pull-down current source, if V_{CCA} is powered.

To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

The RS0108 is available in Green QFN3*3-20L and TSSOP20 packages. It operates over an ambient temperature range of -40°C to +85°C.

Device information (7)						
PART NUMBER	PACKAGE	BODY SIZE (NOM)				
RS0108	TSSOP20(20)	6.50mm×4.40mm				
R50108	QFN3*3-20L(20)	3.00mm×3.00mm				

Device Information ⁽¹⁾

(1) For all available packages, see the orderable addendum at the end of the data sheet.



Functional Block Diagram



Function Block Diagram



Revision History

Note: Page numbers for previous revisions may different from page numbers in the current version.

VERSION	Change Date	Change Item
A.1	2020/12/2	Initial version completed
A.2	2021/01/09	Add Moisture Sensitivity Level information
A.3	2021/11/01	 Change Recommended Operating Conditions in Page 7@A.2 Version. Add TAPE AND REEL INFORMATION Correct the maximum of OE Input leakage current Add Typical Characteristics



PIN CONFIGURATIONS



PIN DESCRIPTION

F	PIN		TYPE ⁽¹⁾	FUNCTION			
TSSOP20	QFN3*3-20L	NAME	ITPE	FUNCTION			
1	19	A1	I/O	Input/output A1. Reference to V _{CCA} .			
2	20	Vcca	Р	A Port Supply Voltage.1.65V \leq V _{CCA} \leq 5.5V and V _{CCA} \leq V _{CCB} .			
3	1	A2	I/O	Input/output A2. Reference to V _{CCA} .			
4	2	A3	I/O	Input/output A3. Reference to V _{CCA} .			
5	3	A4	I/O	Input/output A4. Reference to V _{CCA} .			
6	4	A5	I/O	Input/output A5. Reference to V _{CCA} .			
7	5	A6	I/O	Input/output A6. Reference to V _{CCA} .			
8	6	A7	I/O	Input/output A7. Reference to V _{CCA} .			
9	7	A8	I/O	Input/output A8. Reference to V _{CCA} .			
10	8	OE	I	Output Enable (Active High). Pull OE low to place all outputs in 3-state mode. Referenced to V_{CCA} .			
11	9	GND	-	Ground.			
12	10	B8	I/O	Input/output B8. Reference to V _{CCB} .			
13	11	B7	I/O	Input/output B7. Reference to V _{CCB} .			
14	12	B6	I/O	Input/output B6. Reference to V _{CCB} .			
15	13	B5	I/O	Input/output B5. Reference to V _{CCB} .			
16	14	B4	I/O	Input/output B4. Reference to V _{CCB} .			
17	15	B3	I/O	Input/output B3. Reference to V _{CCB} .			
18	16	B2	I/O	Input/output B2. Reference to V _{CCB} .			



19	17	V _{CCB}	Р	B Ports Supply Voltage.2.3V \leq V _{CCB} \leq 5.5V.
20	18	B1	I/O	Input/output B1. Reference to V _{CCB} .
-	Exposed Pad	GND	-	Exposed pad should be soldered to PCB board and connected to GND or left floating.

(1) I=input, O=output, I/O=input and output, P=power



SPECIFICATIONS

Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

SYMBOL	PARAMETER			MAX	UNIT
V _{CCA}	Supply Voltage Range	-0.3	6.0	V	
Vссв	Supply Voltage Range		-0.3	6.0	V
		A port	-0.3	6.0	
VI ⁽²⁾	Input Voltage Range	B port	-0.3	6.0	v
		OE	-0.3	6.0	V
Vo ⁽²⁾	Voltage range applied to any output in the high-	A port	-0.3	6.0	v
VO(-/	impedance or power-off state	B port	-0.3	6.0	
Vo ⁽²⁾⁽³⁾	Voltage range applied to any output in the high or	A port	-0.3	V _{CCA} +0.3	v
VO(=)(0)	low state	B port	-0.3	V _{ссв} +0.3	v
I _{IK}	Input clamp current	V1<0		-50	mA
l _{ок}	Output clamp current	Vo<0		-25	mA
lo	Continuous output current			±50	mA
	Continuous current through V _{CCA} , V _{CCB} or GND		±100	mA	
TJ	Junction Temperature		150	°C	
T _{stg}	Storage temperature		-65	+150	

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of V_{CCA} and V_{CCB} are provided in the recommended operating conditions table.

ESD Ratings

			VALUE	UNIT
V(sop)	Electrostatic discharge	Human-body model (HBM)	±5000	V
V _(ESD) Electrostatic discharge	Machine Model (MM)	±400	V	



Recommended Operating Conditions

V_{CCI} is the supply voltage associated with the input port. V_{CCO} is the supply voltage associated with the output port.

PARAMETER		CONDITIONS	MIN	ТҮР	MAX	UNIT
Supply voltage ⁽¹⁾	V _{CCA}	V _{CCA}			5.5	V
Supply vollage (V _{CCB}		2.3		5.5	v
	A-port I/Os	$V_{CCA} = 1.65 V \text{ to } 1.95 V$ $V_{CCB} = 2.3 V \text{ to } 5.5 V$	V _{CCI} - 0.2		V _{CCI}	V
High-level input voltage	A-poir i/Os	$V_{CCA} = 2.3 V \text{ to } 5.5 V$ $V_{CCB} = 2.3 V \text{ to } 5.5 V$	Vcci - 0.4		Vcci	V
(Vін)	B-port I/Os	$V_{CCA} = 1.65 V \text{ to } 5.5 V$ $V_{CCB} = 2.3 V \text{ to } 5.5 V$	Vcci - 0.4		Vccı	V
	OE input	$V_{CCA} = 1.65 V \text{ to } 5.5 V$ $V_{CCB} = 2.3 V \text{ to } 5.5 V$	V _{CCA} × 0.8		5.5	V
	A-port I/Os	V _{CCA} = 1.65 V to 5.5 V V _{CCB} = 2.3 V to 5.5 V	0		0.15	V
Low-level input voltage (V _{IL})	B-port I/Os	V _{CCA} = 1.65 V to 5.5 V V _{CCB} = 2.3 V to 5.5 V	0		0.15	V
	OE input	V _{CCA} = 1.65 V to 5.5 V V _{CCB} = 2.3 V to 5.5 V	0		V _{CCA} × 0.25	V
		A-port I/Os push-pull driving			10	ns/V
Input transition rise or fall rate($\Delta t / \Delta v$)		B-port I/Os push-pull driving			10	ns/V
		Control input			10	ns/V
T _A Operating free-air tem	perature	-	-40		85	°C

(1) V_{CCA} must be less than or equal to V_{CCB} . (2) The maximum V_{IL} value is provided to ensure that a valid V_{OL} is maintained. The V_{OL} value is V_{IL} plus the voltage drop across the pass gate transistor.



PACKAGE/ORDERING INFORMATION

PRODUCT	ORDERING NUMBER	TEMPERATURE RANGE	PACKAGE LEAD	PACKAGE MARKING (1)	MSL ⁽²⁾	PACKAGE OPTION
RS0108	RS0108YTQC20	-40°C ~+85°C	QFN3*3-20L	RS0108	MSL3	Tape and Reel,5000
	RS0108YQ20	-40°C ~+85°C	TSSOP20	RS0108	MSL3	Tape and Reel,4000

NOTE:

(1) There may be additional marking, which relates to the lot trace code information(data code and vendor code), the logo or the environmental category on the device.

(2) MSL, The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications.



Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (1) (2) (3)

PA	RAMETER	CONDITIONS	VCCA	Vссв	TEMP	MIN	TYP	MAX	UNITS
Vона	Port A output high voltage	$I_{OH} = -20 \ \mu A$ $V_{IB} \ge V_{CCB} - 0.4V$	1.65V to 5.5V	2.3V to 5.5V	Full	V _{CCA} × 0.7		5.5	
Vola	Port A output low voltage	I _{OL} = 1mA V _{IB} ≤ 0.15 V	1.65V to 5.5V	2.3V to 5.5V	Full			0.3	V
Vонв	Port B output high voltage	$I_{OH} = -20 \ \mu A$ $V_{IA} \ge V_{CCA} - 0.4$ V	1.65V to 5.5V	2.3V to 5.5V	Full	V _{ССВ} × 0.7			v
Volb	Port B output low voltage	$I_{OL} = 1mA$ $V_{IA} \le 0.15 V$	1.65V to 5.5V	2.3V to 5.5V	Full			0.3	
	Input				+25°C			±2	
lı	leakage current	OE	1.65V to 5.5V	2.3V to 5.5V	Full			±3	μA
	Partial	A Ports	0V	0V to 5.5V	+25°C			±0.5	μA
l _{off}	power		00	00 10 5.50	Full			±1	μΑ
loff	down current	B Ports	0V to 5.5V	0V	+25°C			±0.5	μA
		DTONS	07 10 0.07		Full			±1	μ
	High- impedance		_	+25°C			±0.5		
loz	State output current	OE=0V	1.65V to 5.5V	2.3V to 5.5V	Full			±1	μA
	., .		1.65V to V_{CCB}	2.3V to 5.5V	Full			2.0	
ICCA	V _{CCA} supply current	$V_1 = V_0 = open$ $I_0 = 0$	5.5V	0V	Full			2.0	μA
			0V	5.5V	Full			-1	
) (averali (1.65V to V _{CCB}	2.3V to 5.5V	Full			20	
Іссв	V _{CCB} supply current	$V_1 = V_0 = open$ $I_0 = 0$	5.5V	0V	Full			-1	μA
		-	0V	5.5V	Full			1	
І _{ССА} + Іссв	Combined supply current	$V_I = V_{CCI} \text{ or } GND$ $I_O = 0$	1.65V to V _{CCB}	2.3V to 5.5V	Full			30	μA
Iccza	V _{CCA} supply current	$V_I = V_{CCI} \text{ or } 0V$ $I_0 = 0, OE=0V$	1.65V to V_{CCB}	2.3V to 5.5V	Full			1	μA
Ісств	V _{CCB} supply current	$V_I = V_{CCI} \text{ or } 0V$ $I_0 = 0, OE=0V$	2.3V to 5.5V	2.3V to 5.5V	Full			1	μΑ
Cı	Input capacitance	OE	3.3V	3.3V	+25°C		2.5		pF
	Input-to- output	A port	3.3V	3.3V	+25°C		5		
CIO	internal capacitance	B port	3.3V	3.3V	+25°C		5		pF

(1) V_{CCI} is the V_{CC} associated with the input port. (2) V_{CCO} is the V_{CC} associated with the output port (3) V_{CCA} must be less than or equal to V_{CCB} .

Timing Requirements

Vcca=1.8V±0.15 V

		V _{CCB} =2.5V ±0.2V	V _{CCB} =3.3V ±0.2V	V _{ссв} =5V ±0.2V		
		ТҮР	ТҮР	ТҮР	UNIT	
Data nata	Push-pull driving	21	22	24	Mbps	
Data rate	Open-drain driving	2	2	2	iviops	
Pulse duration(t _w)	Push-pull driving (data inputs)	47	45	41	20	
	Open-drain driving (data inputs)	500	500	500	ns	

Vcca=2.5V±0.15 V

		V _{CCB} =2.5V ±0.2V	V _{CCB} =3.3V ±0.2V	V _{CCB} =5V ±0.2V		
		ТҮР	ТҮР	ТҮР	UNIT	
Data nata	Push-pull driving	20	22	24	Mhaa	
Data rate	Open-drain driving	2	2	2	Mbps	
Pulse	Push-pull driving (data inputs)	50	45	41	20	
duration(t _w)	Open-drain driving (data inputs)	500	500	500	ns	

Vcca=3.3V±0.15 V

		V _{CCB} =3.3V ±0.2V	V _{CCB} =5V ±0.2V	UNIT
		ТҮР	ТҮР	UNIT
	Push-pull driving	23	24	Mhaa
Data rate	Open-drain driving	2	2	Mbps
Pulse duration(t _w)	Push-pull driving (data inputs)	43	41	
	Open-drain driving (data inputs)	500	500	ns

Vcca=5V±0.15 V

		V _{CCB} =5V ±0.2V	
		ТҮР	UNIT
Data rata	Push-pull driving	24	Mhaa
Data rate	Open-drain driving	2	Mbps
Pulse	Push-pull driving (data inputs)	41	
duration(t _w)	Open-drain driving (data inputs)	500	ns



Switching Characteristics: V_{CCA}=1.8V ± 0.15V

	·			V _{CCB} =2.5V±0.2V	V _{CCB} =3.3V±0.2V	V _{CCB} =5V±0.2V	UNITS	
PA	RAMETER		ONDITIONS	ТҮР	ТҮР	ТҮР	UNITS	
t _{PHL}	Propagation delay time	A-to-B	Push-pull driving	2.5	3.1	4.5	ns	
IPHL	high-to-low output	А-10-В	Open-drain driving	26.1	26.4	26.6	115	
t _{PLH}	Propagation delay time	A-to-B	Push-pull driving	4.2	3.7	3.6	ns	
IPLH	low-to-high output	A-10-D	Open-drain driving	221	183	143	115	
t PHL	Propagation delay time	B-to-A	Push-pull driving	2.1	2.0	2.2		
IPHL	high-to-low output	D-IO-A	Open-drain driving	26.1	26.1	26.2	ns	
	Propagation delay time		Push-pull driving	1.8	1.6	1.5		
t _{PLH}	low-to-high output	B-to-A	Open-drain driving	173	89	66	ns	
t _{en}	Enable time	OE-to-A or B		25	21	19	ns	
t _{dis}	Disable time	OE-to-A o	r B	1250	1250	1250	ns	
	Input rise	A port	A port	Push-pull driving	6.9	6.1	5.6	
t _{rA}	time	rise time	Open-drain driving	118	39	13	ns	
	Input rise	B port	Push-pull driving	5.8	4.8	4.1		
t _{rB}	time	rise time	Open-drain driving	166	127	75	ns	
	Input fall	A port	Push-pull driving	3.0	2.8	2.7		
t _{fA}	time	fall time	Open-drain driving	1.9	1.7	1.6	ns	
	Input foll	B port	Push-pull driving	4.8	6.2	8.4		
t _{fB}	Input fall B port time fall time				2.4 2.8		ns	
tsk(O)	Skew(time), output	Channel-to-Channel Skew		0.5	0.5	0.5	ns	
		Push-pull	driving	21	22	24	Mbps	
Maxim	ium data rata	Open-drai	in driving	2	2	2		



Switching Characteristics: V_{CCA}=2.5V ± 0.15V

PARAMETER		CONDITIONS		V _{CCB} =2.5V±0.2V	V _{ссв} =3.3V±0.2V	V _{CCB} =5V±0.2V	UNITS	
PA	RAMETER		UNDITIONS	ТҮР	ТҮР	ТҮР	UNITS	
	Propagation delay time		Push-pull driving	2.8	3.4	5.0		
t PHL	high-to-low output	A-to-B	Open-drain driving	26.3	26.5	26.6	ns	
	Propagation		Push-pull driving	2.7	2.5	2.4		
tplH	delay time low-to-high output	A-to-B	Open-drain driving	198	169	131	ns	
	Propagation		Push-pull driving	2.5	2.4	2.5		
t _{PHL}	delay time high-to-low output	B-to-A	Open-drain driving	26.4	26.5	26.6	ns	
	Propagation		Push-pull driving	2.1	2.0	1.9		
t PLH	delay time low-to-high output	B-to-A	Open-drain driving	196	138	63	ns	
t _{en}	Enable time	OE-to-A or B		24	20	17	ns	
t _{dis}	Disable time	OE-to-A c	or B	1250	1250	1250	ns	
	Input rise	ise A port	Push-pull driving	3.4	2.9	2.7		
t _{rA}	time	rise time			92	13	ns	
	Input rise	B port	Push-pull driving	4.7	3.5	2.7		
t _{rB}	time	rise time	Open-drain driving	160	124	81	ns	
	Input fall	ut fall A port	Push-pull driving	5.1	5.2	5.0		
t fA	time	fall time	Open-drain driving	2.1	2.0	1.8	ns	
	Input fall	B port	Push-pull driving	5.0	6.4	8.7		
t _f ₿	time fall time		Open-drain driving	2.0	2.2	2.8	ns	
tsk(O)	Skew(time), output	Channel-t	o-channel skew	0.5	0.5	0.5	ns	
Maxim	um data rata	Push-pull	driving	20	22	24	Mbps	
ινιαλίΠ	uni uala tala	Open-dra	in driving	2	2	2	Ninha	



Switching Characteristics: V_{CCA}=3.3V ± 0.3V

		CONDITIONS		V _{CCB} =3.3V±0.2V	V _{CCB} =5V±0.2V		
P	ARAMETER		JONDITIONS	ТҮР	ТҮР	UNITS	
tрнL	Propagation delay time	A-to-B	Push-pull driving	3.6	5.1	ns	
THE	high-to-low output	N lo B	Open-drain driving	26.4	26.6	113	
tрцн	Propagation delay time	A-to-B	Push-pull driving	2.3	2.1	ns	
IPLH	low-to-high output	A-10-B	Open-drain driving	155	109	115	
t _{PHL}	Propagation delay time	B-to-A	Push-pull driving	3.1	3.3	ns	
PHL	high-to-low output	D-10-A	Open-drain driving	26.5	26.7	113	
t PLH	Propagation delay time	B-to-A	Push-pull driving	1.9	1.8	ns	
IPLH	low-to-high output	D-10-A	Open-drain driving	158	87		
t _{en}	Enable time	OE-to-A or B		19	15	ns	
t _{dis}	Disable time	OE-to-A or B	OE-to-A or B		1250	ns	
+.	Input rise time	A port rise	Push-pull driving	2.3	2.1		
t _{rA}	input rise time	time	Open-drain driving	117	48	ns	
t _{rB}	Input rise time	B port rise	Push-pull driving	3.0	2.4		
ιrΒ	input rise time	time	Open-drain driving	117	75	ns	
t _{fA}	Input fall time	A port fall	Push-pull driving	8.0	7.6	ns	
ι _t Α	input iair time	time	Open-drain driving	2.2	2.1	115	
tro	Input fall time	B port fall	Push-pull driving	8.2	10.8	ns	
t _{fB}	input iair time	time	Open-drain driving	2.1	2.4		
tsk(O)	Skew(time), output	Channel-to-channel skew		0.5	0.5	ns	
Movim	um data rata	Push-pull drivi	ng	23	24	Mhoc	
waxim	um data rata	Open-drain dr	iving	2	2	Mbps	



Switching Characteristics: V_{CCA}=5.0V ± 0.35V

PARAMETER			CONDITIONS	V _{CCB} =5V±0.2V	UNITS	
P	ARAMETER		CONDITIONS	ТҮР		
tрнL	Propagation delay time	A-to-B	Push-pull driving	5.6	- ns	
UP NL	high-to-low output		Open-drain driving	26.8	15	
touu	Propagation delay time	A-to-B	Push-pull driving	2.0	20	
t _{PLH}	low-to-high output	A-10-D	Open-drain driving	155	- ns	
t	Propagation delay time	B-to-A	Push-pull driving	5.8	25	
t _{PHL}	high-to-low output	D-10-A	Open-drain driving	27.5	ns	
t _{PLH}	Propagation delay time	B-to-A	Push-pull driving	1.8	- ns	
IPLH	low-to-high output	D-10-A	Open-drain driving	160	115	
t _{en}	Enable time	OE-to-A or B	OE-to-A or B		ns	
t _{dis}	Disable time	OE-to-A or B		1250	ns	
4.	Input rise time	A part rise time	Push-pull driving	1.9		
t _{rA}	Input rise time	A port rise time	Open-drain driving	105	ns	
4 -	Input rise time	D port rice time	Push-pull driving	2.3		
t _{rВ}	Input rise time	B port rise time	Open-drain driving	95	ns	
t _{fA}	Input fall time	A port fall time	Push-pull driving	9.0	ns	
ЧA	input iaii time	A port fail time	Open-drain driving	2.6	115	
4	Input fall time	B port fall time	Push-pull driving	8.9		
t _f ₿	Input fall time	B port fail time	Open-drain driving	2.5	ns	
tsk(O)	Skew(time), output	Channel-to-chan	Channel-to-channel skew		ns	
N4 -		Push-pull driving		24		
waximum	n data rata	Open-drain drivin	ng	2	Mbps	



Typical Characteristics















V_{CCA}=2.7V V_{IL(A)}=0.15V Figure2: Low-Level Output Voltage vs Low-Level Current



V_{CCA}=1.8V V_{IL(A)}=0.20V Figure4: Low-Level Output Voltage vs Low-Level Current





Typical Characteristics















V_{CCA}=2.7V V_{IL(A)}=0.30V Figure8: Low-Level Output Voltage vs Low-Level Current



VCCA=1.8V VIL(A)=0.40V Figure10: Low-Level Output Voltage vs Low-Level Current





Typical Characteristics









V_{CCA}=2.7V V_{IL(A)}=0.50V Figure14: Low-Level Output Voltage vs Low-Level Current



Parameter Measurement Information

Unless otherwise noted, all input pulses are supplied by generators having the following characteristics:

- PRR 10 MHz
- Zo = 50 Ω
- dv/dt \ge 1 V/ns

Note: All input pulses are measured one at a time, with one transition per measurement.



Figure 16. Data Rate, Pulse Duration, Propagation Delay, Output Rise And Fall Time Measurement Using A Push-Pull Driver



Figure 17. Data Rate, Pulse Duration, Propagation Delay, Output Rise And Fall Time Measurement Using An Open-Drain Driver



Figure 18. Load Circuit For Enable/Disable Time Measurement

TEST	S1
tpzl ⁽¹⁾ , tplz ⁽²⁾	2 × V _{CCO}
tрнzl ⁽¹⁾ , tрzн ⁽²⁾	Open

(1) t_{PZL} and t_{PZH} are the same as t_{en} .

(2) t_{PLZ} and t_{PHZ} are the same as t_{dis} .





(1) All input pulses are measured one at a time, with one transition per measurement.

Figure 19. Voltage Waveforms Pulse Duration











Feature Description

Overview

The RS0108 device is a directionless voltage-level translator specifically designed for translating logic voltage levels. The A port is able to accept I/O voltages ranging from 1.65 V to 5.5 V, while the B port can accept I/O voltages from 2.3 V to 5.5 V. The device is a pass-gate architecture with edge-rate accelerators (one-shots) to improve the overall data rate. 10-k Ω pullup resistors, commonly used in open-drain applications, have been conveniently integrated so that an external resistor is not needed. While this device is designed for open-drain applications, the device can also translate push-pull CMOS logic outputs.

Architecture

The RS0108 architecture (see Figure 22) is an auto-direction-sensing based translator that does not require a direction-control signal to control the direction of data flow from A to B or from B to A. These two bidirectional channels independently determine the direction of data flow without a direction-control signal. Each I/O pin can be automatically reconfigured as either an input or an output, which is how this auto-direction feature is realized.



Figure 22. Architecture of a RS0108 Cell

The RS0108 employs two key circuits to enable this voltage translation:

- 1) An N-channel pass-gate transistor topology that ties the A-port to the B-port
- 2) Output one-shot (O.S.) edge-rate accelerator circuitry to detect and accelerate rising edges on the A or B Ports.

Input Driver Requirements

The continuous dc-current "sinking" capability is determined by the external system-level open-drain (or push pull) drivers that are interfaced to the RS0108 I/O pins. Since the high bandwidth of these bidirectional I/O circuits is used to facilitate this fast change from an input to an output and an output to an input, they have a modest dc-current "sourcing" capability of hundreds of micro-Amps, as determined by the internal 10-k Ω pullup resistors.

The fall time (t_{fA} , t_{fB}) of a signal depends on the edge-rate and output impedance of the external device driving RS0108 data I/Os, as well as the capacitive loading on the data lines.

Similarly, the t_{PHL} and max data rates also depend on the output impedance of the external driver. The values for t_{fA} , t_{fB} , t_{PHL} , and maximum data rates in the data sheet assume that the output impedance of the external driver is less than 50 Ω .



Feature Description

Output Load Considerations

We recommend careful PCB layout practices with short PCB trace lengths to avoid excessive capacitive loading and to ensure that proper O.S. triggering takes place. PCB signal trace-lengths should be kept short enough such that the round-trip delay of any reflection is less than the one-shot duration. This improves signal integrity by ensuring that any reflection sees a low impedance at the driver. The O.S. circuits have been designed to stay on for approximately 30 ns. The maximum capacitance of the lumped load that can be driven also depends directly on the one-shot duration. With very heavy capacitive loads, the one-shot can time-out before the signal is driven fully to the positive rail. The O.S. duration has been set to best optimize trade-offs between dynamic ICC, load driving capability, and maximum bit-rate considerations. Both PCB trace length and connectors add to the capacitance that the RS0108 device output sees, so it is recommended that this lumped-load capacitance be considered to avoid O.S. retriggering, bus contention, output signal oscillations, or other adverse system-level affects.

Enable and Disable

The RS0108 device has an OE input that is used to disable the device by setting OE low, which places all I/Os in the Hi-Z state. The disable time (t_{dis}) indicates the delay between the time when OE goes low and when the outputs are disabled (Hi-Z). The enable time (t_{en}) indicates the amount of time the user must allow for the one-shot circuitry to become operational after OE is taken high.

Pullup or Pulldown Resistors on I/O Lines

Each A-port I/O has an internal $10-k\Omega$ pullup resistor to V_{CCA}, and each B-port I/O has an internal $10-k\Omega$ pullup resistor to V_{CCB}. If a smaller value of pullup resistor is required, an external resistor must be added from the I/O to V_{CCA} or V_{CCB} (in parallel with the internal 10-k Ω resistors). Adding lower value pull-up resistors will affect V_{OL} levels, however. The internal pull-ups of the RS0108 are disabled when the OE pin is low.



Application Information

The RS0108 device can be used to bridge the digital-switching compatibility gap between two voltage nodes to successfully interface logic threshold levels found in electronic systems. It should be used in a point-to-point topology for interfacing devices or systems operating at different interface voltages with one another. Its primary target application use is for interfacing with open-drain drivers on the data I/Os such as I₂C or 1-wire, where the data is bidirectional and no control signal is available. The device can also be used in applications where a push-pull driver is connected to the data I/Os, but the RS0108 might be a better option for such push-pull applications.

Typical Application



Figure 23. Typical Application Circuit

PACKAGE OUTLINE DIMENSIONS TSSOP20





RECOMMENDED LAND PATTERN (Unit: mm)



Symbol	Dimensions	In Millimeters	Dimensions In Inches			
Symbol	Min	Мах	Min	Max		
A		1.200		0.047		
A1	0.050	0.150	0.002	0.006		
A2	0.800	1.050	0.031	0.041		
b	0.200	0.280	0.008	0.011		
с	0.130	0.170	0.005	0.007		
D	6.400	6.600	0.252	0.260		
E	4.300	4.500	0.169	0.177		
E1	6.200	6.600	0.244	0.260		
e	0.650	(BSC)	0.026	BSC)		
L	0.450	0.750	0.018	0.030		
н	0.250(TYP)		0.010(TYP)			
θ	0°	8°	0°	8°		



QFN3*3-20L



SIDE VIEW

• • • •	Dimensions	In Millimeters	Dimension	s In Inches		
Symbol	Min	Max	Min	Мах		
А	0.700	0.800	0.028	0.031		
A1	0.000	0.050	0.000	0.002		
A2	0.20	3REF	0.008	B REF		
D	2.950	3.050	0.116	0.120		
E	2.950	3.050	0.116	0.120		
D1	1.550	1.650	0.061	0.065		
E1	1.550	1.650	0.061	0.065		
К	0.30	0REF	0.012	2REF		
K1	0.40	0REF	0.016	6REF		
b	0.150	0.250	0.006	0.010		
b1	0.15	0REF	0.006	0.006REF		
е	0.40	OBSC	0.016BSC			
L	0.350	0.450	0.014	0.018		

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSION



NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF TAPE AND REEL

Package Type	Reel Diameter	Reel Width (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
TSSOP20	13"	12.4	6.75	6.95	1.20	4.0	8.0	2.0	12.0	Q1
QFN3*3-20L	13"	12.4	3.35	3.35	1.13	4.0	8.0	2.0	12.0	Q1